

Search Notes				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/621,708		QIAN, XUEJUN	
				Examiner		Art Unit	
				Tae H. Yoon		1714	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
Class	Subclass	Date	Examiner			DATE	EXMR
523	116	3-9-06	3	EAST		11-8-06	3
	118			Inventor Search		3-9-06	3
070		6-28-06	3	EAST		8-31-06	3
INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				